## Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

10085951

BROWN ET AL.

Examiner

Nguyen-Ba, Hoang-Vu A

Art Unit 2192

Notes	Date	E	Examiner
East Search: USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB	2/15/06	HAN	
717//108,114,116,119; 718/1, 100, 102, 107; 719/310, 316 text search only, see search history	2/15/06	HAN	
Non-Patent Literature Search: Google	2/15/06	HAN	-
Interference Search See search history	2/15/06	HAN	· - · · · · · · · · · · · · · · · · · ·
700/121 text search	2/16/06	HAN	
U.S. Patent and Trademark Office		Part of Paper No.:	20060216

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Class	Sub Class	Date		Examiner	
719	316	2/15/06	HAN	· ·	
717	108, 116	2/15/06	HAN		
700	121	2/16/06	HAN		
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